

Notice of References Cited	Application/Control No. 10/586,048		Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner SANG Y. PAIK		Art Unit 3742	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0119955	06-2004	Tanaka, Koichiro	355/051
*	B	US-2006/0019474	01-2006	Inui et al.	438/487
*	C	US-6,800,541	10-2004	Okumura, Hiroshi	438/487
*	D	US-6,524,977	02-2003	Yamazaki et al.	438/799
*	E	US-6,393,042	05-2002	Tanaka, Koichiro	372/101
*	F	US-5,864,430	01-1999	Dickey et al.	359/559
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.